

STGP10NB60SFP

N-CHANNEL 10A - 600V - TO-220FP PowerMesh™ IGBT

TYPE	V _{CES}	V _{CE(sat)}	Ic
STGP10NB60SFP	600	< 1.7 V	10 A

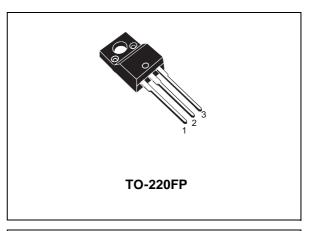
- HIGHT INPUT IMPEDANCE (VOLTAGE DRIVEN)
- LOW ON-VOLTAGE DROP
- HIGH CURRENT CAPABILITY
- OFF LOSSES INCLUDE TAIL CURRENT

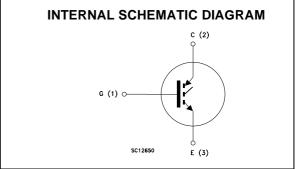


Using the latest high voltage technology based on a patented strip layout, STMicroelectronics has designed an advanced family of IGBTs, the PowerMESH™ IGBTs, with outstanding performances. The suffix "S" identifies a family optimized achieve minimum on-voltage drop for low frequency applications (<1kHz).

APPLICATIONS

- LIGHT DIMMER
- STATIC RELAYS
- MOTOR CONTROL





ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Value	Unit
V _{CES}	Collector-Emitter Voltage (V _{GS} = 0)	600	V
V _{ECR}	Reverse Battery Protection	20	V
V _{GE}	Gate-Emitter Voltage	± 20	V
Ic	Collector Current (continuous) at T _C = 25°C	20	Α
I _C	Collector Current (continuous) at T _C = 100°C	10	Α
I _{CM} (■)	Collector Current (pulsed)	80	А
P _{TOT}	Total Dissipation at T _C = 25°C	31.5	W
	Derating Factor	0.21	W/°C
T _{stg}	Storage Temperature	-65 to 150	°C
Tj	Max. Operating Junction Temperature	150	°C

(•) Pulse width limited by safe operating area

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THERMAL DATA

Rthj-case	Thermal Resistance Junction-case Max	4.7	°C/W
Rthj-amb	Thermal Resistance Junction-ambient Max	62.5	°C/W
Rthc-sink	Thermal Resistance Case-sink Typ	0.5	°C/W

ELECTRICAL CHARACTERISTICS (TCASE = 25 °C UNLESS OTHERWISE SPECIFIED) OFF

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
V _{BR(CES)}	Collector-Emitter Break-down Voltage	$I_C = 250 \mu A, V_{GE} = 0,$	600			V
V _{BR(CES)}	Emitter Collector Break-down Voltage	$I_C = 1 \text{ mA}, V_{GE} = 0,$	20			V
I _{CES}	Collector cut-off Current (V _{GE} = 0)	V_{CE} = Max Rating , T_j =25 °C V_{CE} = Max Rating , T_j =125 °C			10 100	μA μA
I _{GES}	Gate-Emitter Leakage Current (V _{CE} = 0)	V _{GE} = ± 20V , V _{CE} = 0			± 100	nA

ON (1)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
V _{GE(th)}	Gate Threshold Voltage	$V_{CE} = V_{GE}$, $I_C = 250\mu A$	2.5		5	V
V _{CE(SAT)}	Collector-Emitter Saturation Voltage	V _{GE} =15V, I _C = 5 A, Tj= 25°C V _{GE} =15V, I _C = 10 A, Tj= 25°C V _{GE} =15V, I _C = 10 A, Tj= 125°C		1.15 1.35 1.25	1.7	V V V

DYNAMIC

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
9fs	Forward Transconductance	V _{CE} = 25 V , I _C =10 A	5			S
C _{ies}	Input Capacitance	$V_{CE} = 25V, f = 1 \text{ MHz}, V_{GE} = 0$		610		pF
Coes	Output Capacitance			65		pF
C _{res}	Reverse Transfer Capacitance			12		pF
Qg	Gate Charge	V _{CE} = 400V, I _C = 10 A, V _{GE} = 15V		33		nC
I _{CL}	Latching Current	V _{clamp} = 480V, RG= 1kΩ, Tj= 125°C	20			А

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SWITCHING ON

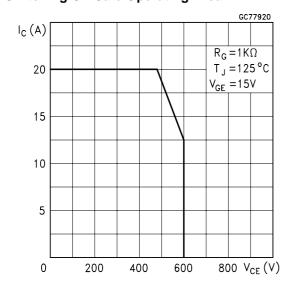
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on Delay Time	V _{CC} = 480 V, I _C = 10 A		0.7		μs
t _r	Rise Time	$R_G = 1K\Omega$, $V_{GE} = 15 V$		0.46		μs
(di/dt) _{on} Eon	Turn-on Current Slope Turn-on Switching Losses	V_{CC} = 480 V, I_{C} = 10 A R_{G} =1K Ω , V_{GE} = 15 V		8 0.6		A/µs mJ

SWITCHING OFF

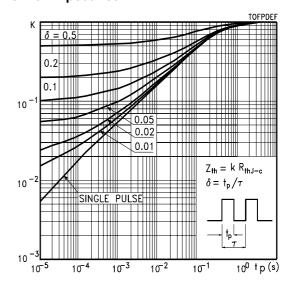
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
t _c	Cross-over Time	V _{clamp} = 480 V, I _C = 10 A,		2.2		μs
$t_r(V_{off})$	Off Voltage Rise Time	$R_{GE} = 1K \Omega$, $V_{GE} = 15 V$		1.2		μs
t _f	Fall Time			1.2		μs
E _{off} (**)	Turn-off Switching Loss			5.0		mJ
t _c	Cross-over Time	$V_{clamp} = 480 \text{ V}, I_{C} = 10 \text{ A},$		3.8		μs
$t_r(V_{off})$	Off Voltage Rise Time	$R_{GE} = 1K\Omega$, $V_{GE} = 15 V$ Ti = 125 °C		1.2		μs
t _f	Fall Time	., = 123 3		1.9		μs
E _{off} (**)	Turn-off Switching Loss			8.0		mJ

^(●)Pulsed: Pulse duration = 300 µs, duty cycle 1.5 %. (1)Pulse width limited by max. junction temperature. (**)Losses Include Also the Tail

Switching Off Safe Operating Area



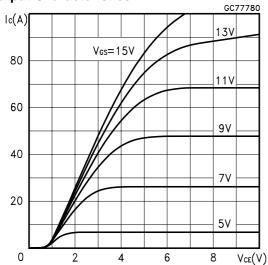
Thermal Impedance



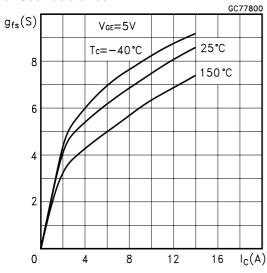
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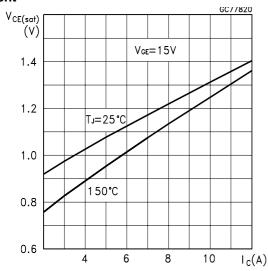
Output Characteristics



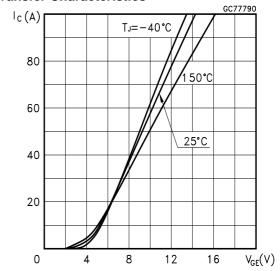
Transconductance



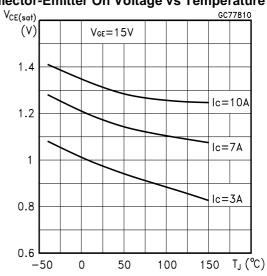
Collector-Emitter On Voltage vs Collector Current



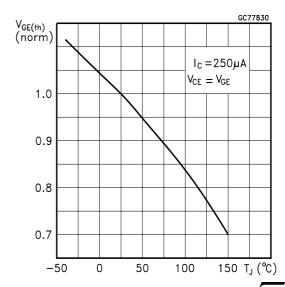
Transfer Characteristics



Collector-Emitter On Voltage vs Temperature

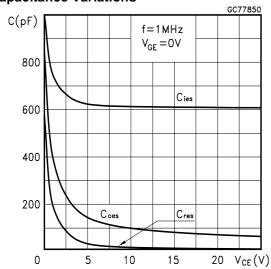


Gate Threshold Voltage vs Temperature

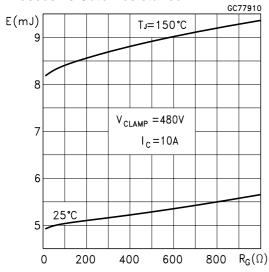


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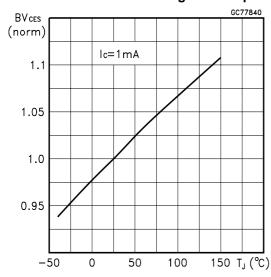
Capacitance Variations



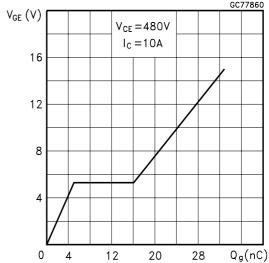
Off Losses vs Gate Resistance



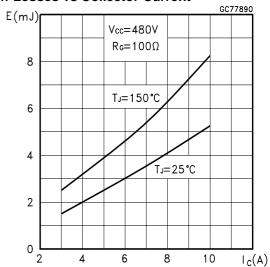
Normalized Break-down Voltage vs Temp.



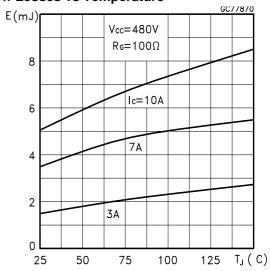
Gate Charge vs Gate-Emitter Voltage



Off Losses vs Collector Current



Off Losses vs Temperature

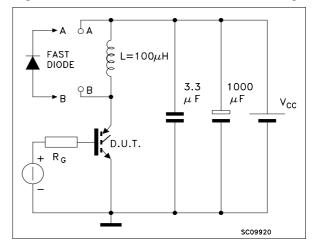


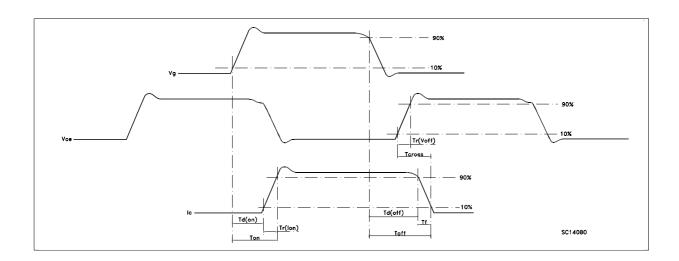
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Fig. 1: Gate Charge test Circuit

 $V_{\rm I} = 20 {\rm V} = {\rm V}_{\rm GMAX}$ $V_{\rm I} = 20 {\rm V} = {\rm V}_{\rm GMAX}$ $V_{\rm I} = 20 {\rm V} = {\rm V}_{\rm GMAX}$ $V_{\rm I} = 20 {\rm V} = {\rm V}_{\rm GMAX}$ $V_{\rm I} = {\rm I}_{\rm I} = {\rm I}_$

Fig. 2: Test Circuit For Inductive Load Switching

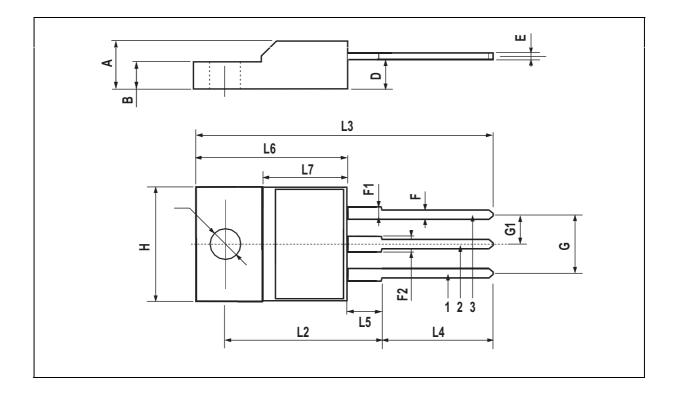




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TO-220FP MECHANICAL DATA

DIM		mm.			inch	
DIM.	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
А	4.4		4.6	0.173		0.181
В	2.5		2.7	0.098		0.106
D	2.5		2.75	0.098		0.108
Е	0.45		0.7	0.017		0.027
F	0.75		1	0.030		0.039
F1	1.15		1.5	0.045		0.067
F2	1.15		1.5	0.045		0.067
G	4.95		5.2	0.195		0.204
G1	2.4		2.7	0.094		0.106
Н	10		10.4	0.393		0.409
L2		16			0.630	
L3	28.6		30.6	1.126		1.204
L4	9.8		10.6	.0385		0.417
L5	2.9		3.6	0.114		0.141
L6	15.9		16.4	0.626		0.645
L7	9		9.3	0.354		0.366
Ø	3		3.2	0.118		0.126



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